

<b>Notice of References Cited</b>	Application/Control No. 10/561,789	Applicant(s)/Patent Under Reexamination YOSHIKATA ET AL.	
	Examiner /Laura S. Weiner/	Art Unit 1726	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,081,317	07-2006	Fujii et al.	429/432
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 02/080299	10-2002	WO	Fujii et al.	
	O				Patent and abstract	
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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